

SEMITOP[®] 3

IGBT Module

SK30GD123

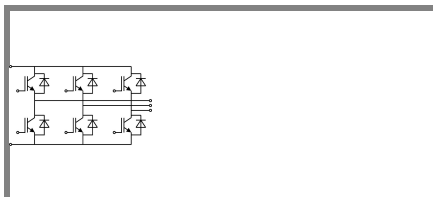
Preliminary Data

Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- N-channel homogeneous silicon structure (NPT-Non punch-through IGBT)
- High short circuit capability
- Low tail current with low temperature dependence
- UL recognized, file no. E63532

Typical Applications

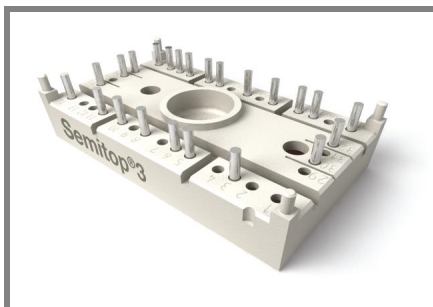
- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



GD

| Absolute Maximum Ratings | | $T_s = 25\text{ °C}$, unless otherwise specified | | | |
|--------------------------|--|---|----|--|--------------------|
| Symbol | Conditions | Values | | | Units |
| IGBT | | | | | |
| V_{CES} | $T_j = 25\text{ °C}$ | 1200 | | | V |
| I_C | $T_j = 125\text{ °C}$ | $T_s = 25\text{ °C}$ | 33 | | A |
| | | $T_s = 80\text{ °C}$ | 22 | | A |
| I_{CRM} | $I_{CRM} = 2 \times I_{Cnom}$ | 50 | | | A |
| V_{GES} | | ± 20 | | | V |
| t_{psc} | $V_{CC} = 600\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125\text{ °C}$ $V_{CES} < 1200\text{ V}$ | 10 | | | μs |
| Inverse Diode | | | | | |
| I_F | $T_j = 150\text{ °C}$ | $T_s = 25\text{ °C}$ | 24 | | A |
| | | $T_s = 80\text{ °C}$ | 17 | | A |
| I_{FRM} | $I_{FRM} = 2 \times I_{Fnom}$ | | | | A |
| I_{FSM} | $t_p = 10\text{ ms}; \text{half sine wave } T_j = 150\text{ °C}$ | 180 | | | A |
| Module | | | | | |
| $I_{t(RMS)}$ | | | | | A |
| T_{vj} | | -40 ... +150 | | | $^{\circ}\text{C}$ |
| T_{stg} | | -40 ... +125 | | | $^{\circ}\text{C}$ |
| V_{isol} | AC, 1 min. | 2500 | | | V |

| Characteristics | | $T_s = 25\text{ °C}$, unless otherwise specified | | | | |
|-----------------|--|---|------|------|------------------|---|
| Symbol | Conditions | min. | typ. | max. | Units | |
| IGBT | | | | | | |
| $V_{GE(th)}$ | $V_{GE} = V_{CE}, I_C = 1\text{ mA}$ | 4,5 | 5,5 | 6,5 | V | |
| I_{CES} | $V_{GE} = 0\text{ V}, V_{CE} = V_{CES}$ | $T_j = 25\text{ °C}$ | 0,15 | | mA | |
| | | $T_j = 125\text{ °C}$ | | | mA | |
| I_{GES} | $V_{CE} = 0\text{ V}, V_{GE} = 30\text{ V}$ | $T_j = 25\text{ °C}$ | 120 | | nA | |
| | | $T_j = 125\text{ °C}$ | | | nA | |
| V_{CE0} | | $T_j = 25\text{ °C}$ | 1,2 | | V | |
| | | $T_j = 125\text{ °C}$ | 1,2 | | V | |
| r_{CE} | $V_{GE} = 15\text{ V}$ | $T_j = 25\text{ °C}$ | 52 | | $\text{m}\Omega$ | |
| | | $T_j = 125\text{ °C}$ | 76 | | $\text{m}\Omega$ | |
| $V_{CE(sat)}$ | $I_{Cnom} = 25\text{ A}, V_{GE} = 15\text{ V}$ | $T_j = 25\text{ °C}_{chiplev.}$ | 2 | 2,5 | 3 | V |
| | | $T_j = 125\text{ °C}_{chiplev.}$ | | 3,1 | 3,7 | V |
| C_{ies} | $V_{CE} = 25, V_{GE} = 0\text{ V}$ | $f = 1\text{ MHz}$ | 1,65 | | nF | |
| C_{oes} | | | 0,25 | | nF | |
| C_{res} | | | 0,11 | | nF | |
| $t_{d(on)}$ | $R_{Gon} = 47\ \Omega$ | $V_{CC} = 600\text{ V}$ $I_{Cnom} = 25\text{ A}$ | 65 | | ns | |
| t_r | | | 100 | | ns | |
| E_{on} | $R_{Goff} = 47\ \Omega$ | $T_j = 125\text{ °C}$ $V_{GE} = \pm 15\text{ V}$ | 3,5 | | mJ | |
| $t_{d(off)}$ | | | 430 | | ns | |
| t_f | | | 35 | | ns | |
| E_{off} | | | 2,5 | | mJ | |
| $R_{th(j-s)}$ | per IGBT | 1 | | | K/W | |



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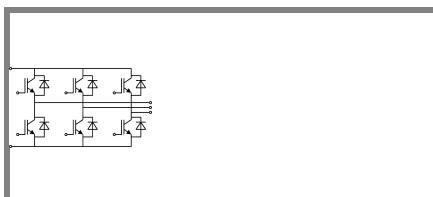
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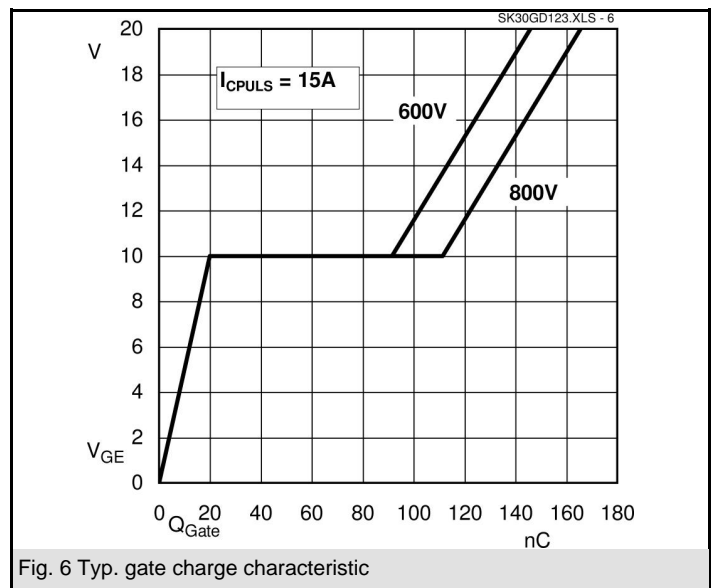
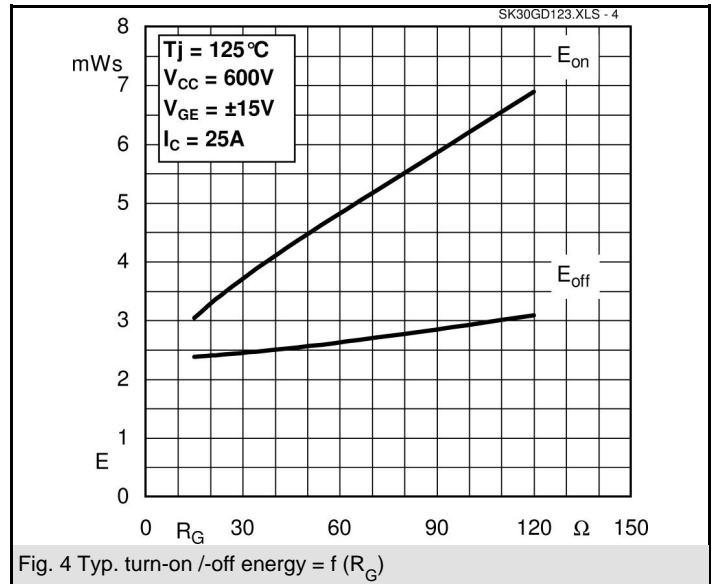
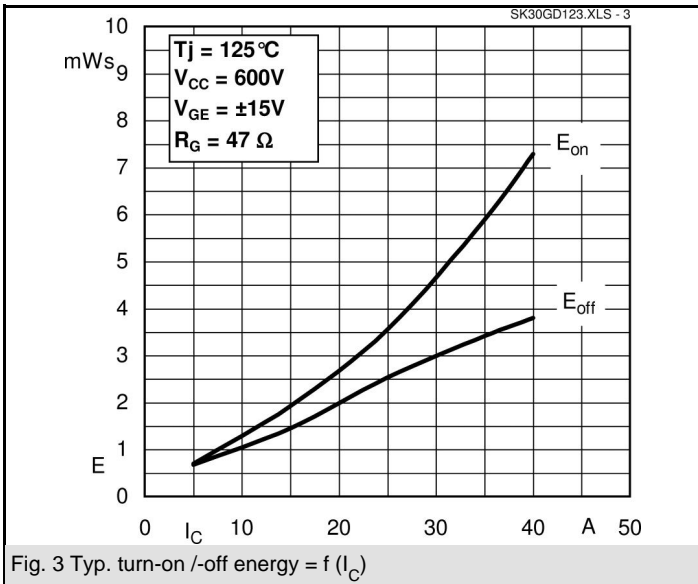
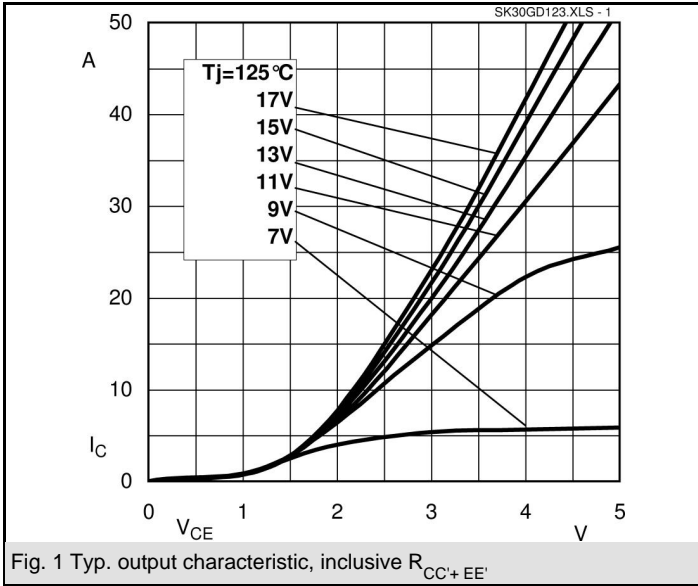
GD

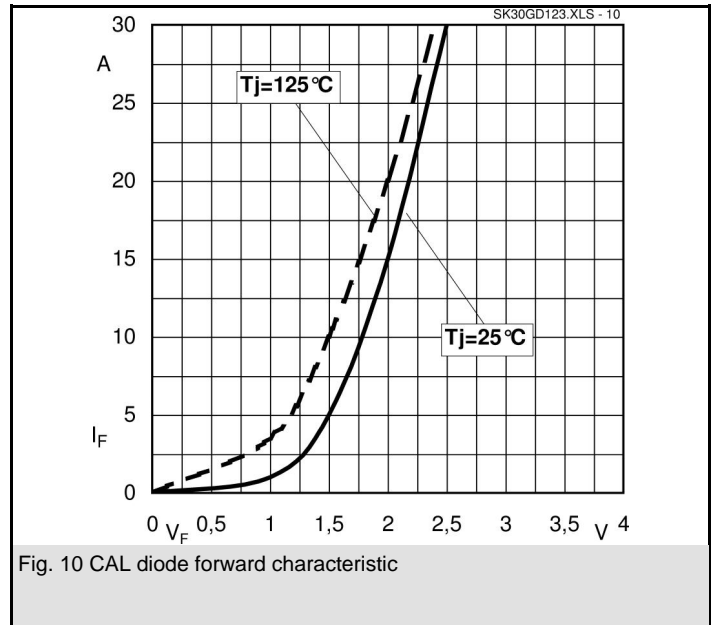
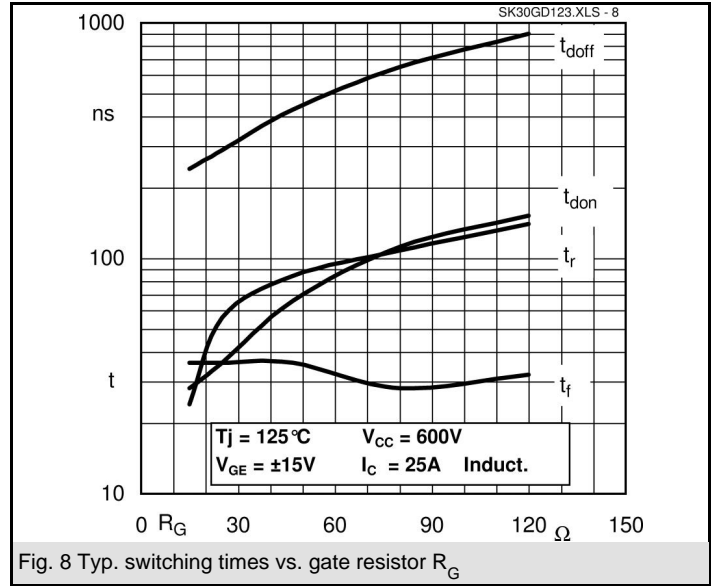
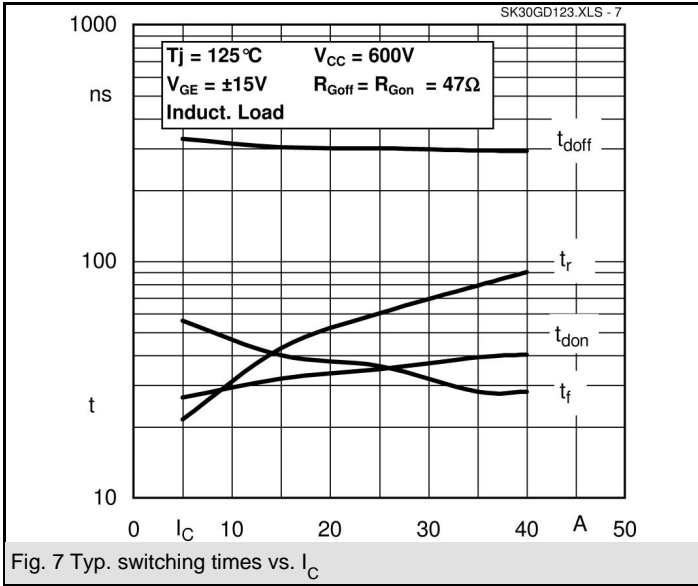
Characteristics

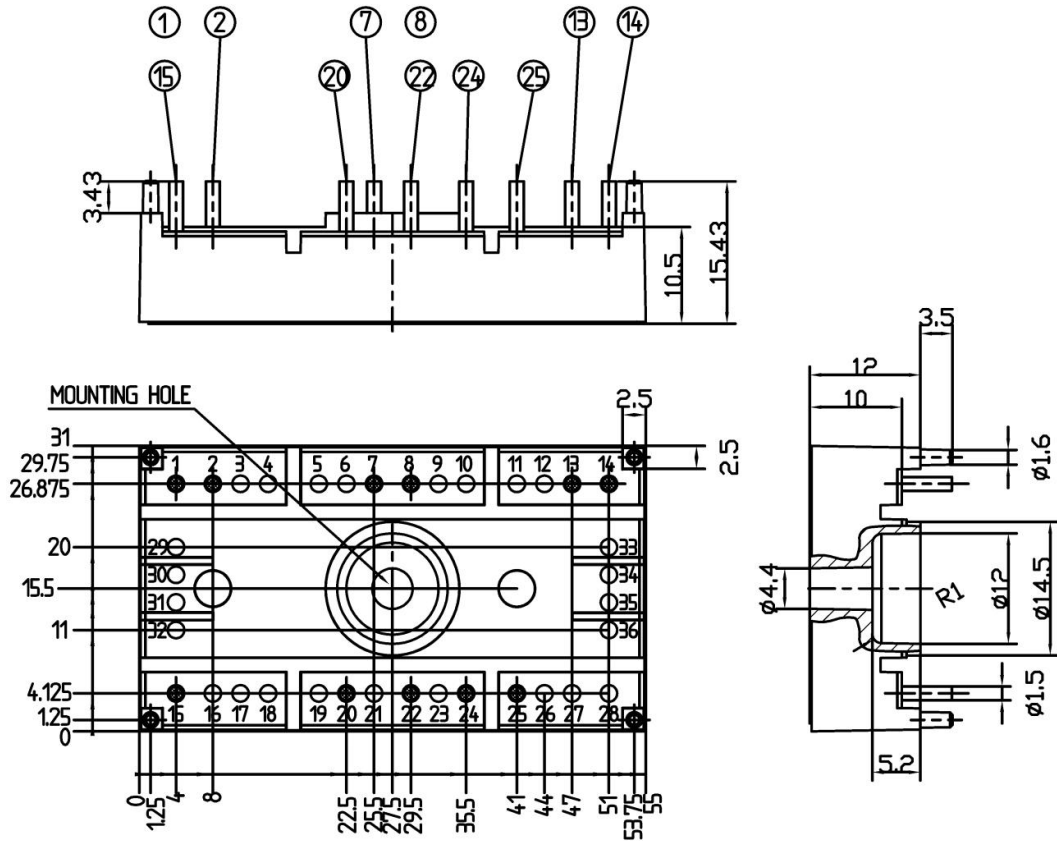
| Symbol | Conditions | min. | typ. | max. | Units |
|----------------------|---|--|------|------|-------|
| Inverse Diode | | | | | |
| $V_F = V_{EC}$ | $I_{Fnom} = 15 \text{ A}; V_{GE} = 0 \text{ V}$ | $T_j = 25 \text{ }^\circ\text{C}_{\text{chiplev.}}$ | 2 | 2,5 | V |
| | | $T_j = 125 \text{ }^\circ\text{C}_{\text{chiplev.}}$ | 1,8 | 2,3 | V |
| V_{F0} | | | 1 | 1,2 | V |
| r_F | | | 53 | 73 | mΩ |
| I_{RRM} | $I_{Fnom} = 15 \text{ A}$ | | 16 | | A |
| Q_{rr} | $di/dt = -200 \text{ A}/\mu\text{s}$ | | 2,7 | | μC |
| E_{rr} | $V_{CC} = 600 \text{ V}$ | | 0,6 | | mJ |
| $R_{th(j-s)D}$ | per diode | | | 1,7 | K/W |
| M_s | to heat sink M1 | 2,25 | | 2,5 | Nm |
| w | | | 30 | | g |

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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Case T12 (Suggested hole diameter, in the PCB, for solder pins and plastic mounting pins: 2mm)

